nannel	2ℓ+1*top-jet*	2ℓ+1*W-jet*+1*b-jet*	2μ+1*b-jet*+2*jets*	$2e$+1*b-jet*+2*jets*	2μ+1*b-jet*	$2e$+1*b-jet*
Background systematics on shape (range between bins)						
ckground α-method	58%	29-32%	10-23%	13-32%	13-42%	17-40%
osure test	8%	3-32%	3-60%	3-60%	3-60%	3-60%
tag	5%	2-6%	4-5%	4-6%	9-12%	6-16%
+jets composition	-	9-44%	3-22%	4-21%	2-13%	4-11%
Signal systematics on shape (range between signal masses)						
le-up	0.1-7.3%	0.5-2.0%	0.2-1.9%	0.1-1.4%	0.1-1.9%	0.2-1.9%
t scale	0.4-9.1%	0.2-1.9%	0.1-1.1%	0.5-1.6%	0.3-0.7%	0.1-1.1%
t resolution	0.1-2.0%	0.1-1.5%	0.1-0.5%	0.1-0.4%	0.1-0.2%	0.1-0.9%
-tag	-	3-8%	-	-	-	-
p-tag	11-18%	-	-	-	-	-
tag	6.9-9.0%	6.8-10.0%	6.2-8.4%	6.0-8.5%	10.5-12.7%	10.4-13.4%
ectron ID	0.4-0.6%	-	-	1.2%	-	1.2%
uon ID	2.8-3.4%	4.3-5.0%	4.3-5.0%	-	4.7-5.0%	-
igger	0.8%	1.1%	1.1%	0.7%	1.1%	0.7%
DF	$\sim$6%	$\sim$6%	$\sim$6%	$\sim$6%	$\sim$6%	$\sim$6%
CD scale	$\sim$14%	$\sim$14%	$\sim$14%	$\sim$14%	$\sim$14%	$\sim$14%
Signal systematics on normalization						
uminosity	2.7%	2.7%	2.7%	2.7%	2.7%	2.7%